DATE: June 15, 2023

产品规格书

SPECIFICATION FOR APPROVAL



| 用户名称 | CUSTOMER: | Quartz 1 |
|-------|------------------------|--|
| 产品描述 | DESCRIPTION: | Monolithic Crystal Filter UM-5*2 45.00MHz |
| 产品部品号 | MANUFACTURER PART NO.: | FT45M30B |
| 用户部品号 | CUSTOMER PART NO: | |
| 使用于机型 | USED IN MODEL: | |

| | 承 认 | APPROVAL |
|------------------|---------------|------------------|
| 工程部 | 品质部 | 采购部 |
| TECHNOLOGY DEPT. | QUALITY DEPT. | PURCHASING DEPT. |
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深圳市炬烜科技有限公司

CHIP SUN TECHNOLOGY CO., LTD

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1. QUARTZ CRYSTAL UNIT SPECIFICATION

1. General

1.1 Model Name: FT45M30B

1.2 Holder type : UM-5*2

2. Electrical Specification:

2.1 Frequency: 45.000MHz

2.2 Mode of Oscillation AT Fundamental

2.3 Pass Band Width: ± 15.0 KHz min (at 3dB)

2.4 Stop Band Width: ± 40 KHz max (at 30dB)

2.5 Pass Band Ripple: 1.0dB max

2.6 Insertion Loss: 2.5dB max

2.7 Attenuation Guarantee : 90dB min $(f0\pm910KHz)$

2.8 Terminating Impedance : IN: $800\Omega//1.5pF$

OUT: 800Ω//1.5pF

Coupling capacitance(C2): 3.0pF

2.9 Insulation resistance : More than 500M ohms at DC 100V

3. Operable temperature range : -20° C To +70°C

4. Storage temperature range : -40° C To $+85^{\circ}$ C

4. Mechanical Data

4.1 Sealing Test : Reduced Pressure (260mmHg of mercury)

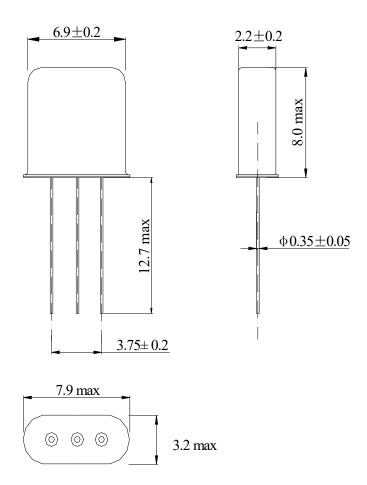
5. Dimensions and marking : Refer to page. 3

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MARKING & DIMENSIONS

*Appearance: Mark Shall Be Clear, Appearance Shall Be Smooth And No Damage.

*Dimensions: Unit: mm



*Marking should be printed as following:

Logo, Nominal Frequency

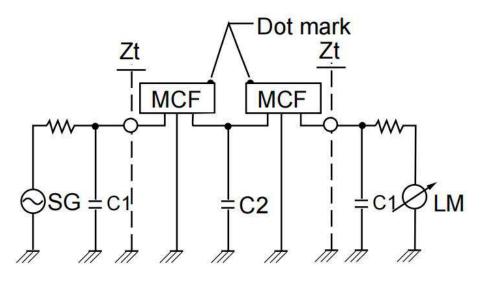
Logo: FT

Nominal Frequency:

Marking: Laser marking or lnk marking.

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TEST CIRCUIT



4-POLE MCF Zt: Terminating Impedance

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| | 6.MECHANICAL/ENVIRONMENTAL CHARACTERISTICS | | | |
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| NO. | ITEM | SPECIFICATIONS | | |
| 6.1 | Resistance to Cold | The units should satisfy its frequency and resistance specifications stated in Table 1 after being subjected to stand at -40±3°C for 2 hours. The units are then allowed to stand at room temperature for approx 2 hours before checking. | | |
| 6.2 | Resistance to Heat | The units should satisfy its frequency and resistance specifications stated in Table 1 after being subjected to stand at 100±2°C for 2 hours. The units are then allowed to stand at room temperature for approx 2 hours before checking. | | |
| 6.3 | Temperature Cycle | The units should satisfy its frequency and resistance specifications stated in Table 1 after the units are subjected to stand in a Low Temperature Chamber at $-40\pm3^{\circ}\mathbb{C}$ for 30 minutes and to stand in a High Temperature Chamber at $100\pm2^{\circ}\mathbb{C}$ for 30 minutes, with 2 to 3 minutes standby at room temperature in between the chamber transfers. This consist of one cycle; and units are subjected continuously for 5 cycles. After cycling, the units are allowed to stand at room temperature for approx 2 hours before checking. | | |
| 6.4 | Aging | The units should satisfy its frequency and resistance specifications stated in Table 1 after the units are subjected to stand 720 (30 days) ±12 hours in an 85±3℃ chamber. The units are allowed to stand at room temperature approx 2 hours before checking. | | |
| 6.5 | Resistance to Damp | The units should satisfy its frequency and resistance specifications stated in Table 1 after the units are subjected to stand in the test chamber capable of maintaining 60±2°C temperature and 90 to 95%(RH) relative humidity for 500 hours. The units are then allowed to stand for approx 2 hours in room temperature before checking | | |
| 6.6 | Bending Strength of Lead Wire Termination | The unit's lead wire should withstand a weight of 450g in mass suspended from its original draw-out axis, and turning the body at a bending rate of 2 to 3 secs. until it IS approx 90° from the original axis; and returning back to its original position at the same bending rate. After this, the same method is repeated on the opposite 90° position. There should be no abnormalities detected on the unit. | | |

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|------|---------------------------------|--|--|--|
| 6.7 | Tensile Strength Termination | The units should withstand a tensile force applied to the termination in the direction of its draw-out axis of up to 900g maintained as is for 30±5 seconds. There should be no abnormalities detected on the unit. | | |
| 6.8 | Solder ability | Under JIS C 5033, at least 90% of the lead wire periphery surface is covered with new solder up to the point where it is dipped on a molten solder. | | |
| 6.9 | Resistance to Soldering Heat | The units are measured for its frequency and resistance in accordance with Table 1 after immersion into molten solder with a temperature of 350±10°C for 3 to 4 seconds and at a depth up to a point 2.0 to 2.5 mm from the base root. | | |
| 6.10 | Dropping Test | Unit Drop Test The units are measured for its frequency and resistance in accordance with Table 1 after allowing the units to fall freely from 20 cm of height 3 times on a firm wood . Shipping Carton Drop Test The units are measured for its frequency and resistance in accordance with Table 1 after dropping the units packaged inside a shipping carton box (randomly positioned) from a 50 cm height in each planar sides of the carton on a concrete floor. | | |
| 6.11 | Vibration Test | The units are measured for its frequency and resistance in accordance with Table 1 after subjecting to 2 hours of vibration with 1.5 mmp-p amplitude with 10-55-10Hz frequency sweep within 1 minute. Three perpendicular plane (axes) of vibration are available; however each unit is allowed to vibrate in only one plane, thus each plane requires approx 1/3 of the total units. | | |

| TABLE 1 | | |
|--------------------------|--|--|
| Electrical Specification | Should satisfy stated in 2.3 2.4 2.5 2.6 | |
| | Should satisfy stated in 2.7 2.10 | |

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